



RADIO TEST REPORT

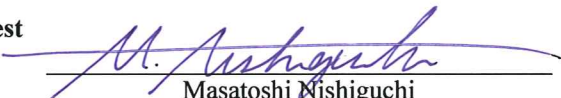
Test Report No. : 10082424H-A

Applicant : DENSO CORPORATION
Type of Equipment : Electronic Key
Model No. : 4AA
Test regulation : FCC Part 15 Subpart C: 2013
FCC ID : HYQ4AA
Test Result : Complied

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2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with above regulation.
4. The test results in this report are traceable to the national or international standards.
5. This test report must not be used by the customer to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the Federal Government.

Date of test: October 18 and 20, 2013

Representative test
engineer:


Masatoshi Nishiguchi
Engineer of WiSE Japan,
UL Verification Service

Approved by:


Masanori Nishiyama
Manager of WiSE Japan,
UL Verification Service



NVLAP LAB CODE: 200572-0

This laboratory is accredited by the NVLAP LAB CODE 200572-0, U.S.A. The tests reported herein have been performed in accordance with its terms of accreditation.
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<http://www.ul.com/japan/jpn/pages/services/emc/about/mark1/index.jsp#nvlap>

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13-EM-F0429

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SECTION 1: Customer information

Company Name	:	DENSO CORPORATION
Address	:	1-1 Showa-cho, Kariya-shi, Aichi-ken, 448-8661 Japan
Telephone Number	:	+81-566-61-5234
Facsimile Number	:	+81-566-25-4792
Contact Person	:	AKIHIRO TAGUCHI

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment	:	Electronic Key
Model No.	:	4AA
Serial No.	:	Refer to Clause 4.2
Rating	:	DC 3.0V
Receipt Date of Sample	:	October 5, 2013
Country of Mass-production	:	Japan, United States of America, and China
Condition of EUT	:	Engineering prototype (Not for Sale: This sample is equivalent to mass-produced items.)
Modification of EUT	:	No Modification by the test lab

2.2 Product Description

Model No: 4AA (referred to as the EUT in this report) is the Electronic Key.
The EUT (4AA) transmits radio wave signals of ASK and FSK.
The radio wave signals of ASK and FSK are not transmitted simultaneously.
Either one of ASK and FSK is transmitted by operator's action.
End users cannot control which of ASK and FSK to be transmitted.

EUT has variations of Type A and Type B.

The difference of these variations is only the outer case.

After test results of the two types were compared, the test was performed only with Type B as its result was the worst one.
Both Type A and Type B have variations in the number of switches, and the maximum number is 6 and 5 respectively.

General Specification

Clock frequency(ies) in the system	:	16 MHz RC oscillator (IC clock) 18.37 MHz Crystal (RF)
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Radio Specification

Radio Type	:	Transceiver
Frequency of Operation	:	314.9MHz
Modulation	:	ASK (A1D) / FSK (F1D)
Power Supply (radio part input)	:	DC 3.0V
Type of Battery	:	One lithium battery
Antenna type	:	Built-in type (Fixed)

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SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification : Test specification: FCC Part 15 Subpart C: 2013, final revised on September 30, 2013 and effective October 30, 2013

Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators
Section 15.231 Periodic operation in the band 40.66 - 40.70MHz
and above 70MHz

* The revision on September 30, 2013 does not affect the test specification applied to the EUT.

3.2 Procedures and results

Item	Test Procedure	Specification	Worst margin	Results	Remarks
Conducted emission	FCC: ANSI C63.4:2003 7. AC powerline conducted emission measurements IC: RSS-Gen 7.2.4	FCC: Section 15.207 IC: RSS-Gen 7.2.4	N/A	N/A*1)	-
Automatically Deactivate	FCC: ANSI C63.4:2003 13. Measurement of intentional radiators IC: -	FCC: Section 15.231(a)(1) IC: RSS-210 A1.1.1	N/A	Complied	Radiated
Electric Field Strength of Fundamental Emission	FCC: ANSI C63.4:2003 13. Measurement of intentional radiators IC: RSS-Gen 4.8	FCC: Section 15.231(b) IC: RSS-210 A1.1.2	[ASK] 6.5dB 314.900MHz Horizontal PK with Duty factor [FSK] 7.9dB 314.900MHz Horizontal PK with Duty factor	Complied	Radiated
Electric Field Strength of Spurious Emission	FCC: ANSI C63.4:2003 13. Measurement of intentional radiators IC: RSS-Gen 4.9	FCC: Section 15.205 Section 15.209 Section 15.231(b) IC: RSS-210 A1.1.2, 2.5.1 RSS-Gen 7.2.5	[ASK] 1.1dB 3149.000MHz Horizontal PK with Duty factor [FSK] 2.5dB 2834.100MHz Horizontal PK with Duty factor	Complied	Radiated
-20dB Bandwidth	FCC: ANSI C63.4:2003 13. Measurement of intentional radiators IC: -	FCC: Section 15.231(c) IC: Reference data	N/A	Complied	Radiated
Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422. *1) The test is not applicable since the EUT does not have AC Mains.					

FCC 15.31 (e)

This test was performed with the New Battery (DC 3.0V) and the constant voltage was supplied to the EUT during the tests. Therefore, the EUT complies with the requirement.

FCC Part 15.203 Antenna requirement

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

3.3 Addition to standard

Item	Test Procedure	Specification	Worst margin	Results	Remarks
99% Occupied Bandwidth	IC: RSS-Gen 4.6.1	IC: RSS-Gen 4.6.1	N/A	Complied	Radiated

Other than above, no addition, exclusion nor deviation has been made from the standard.

3.4 Uncertainty

EMI

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.

Test room (semi-anechoic chamber)	Radiated emission						
	(3m*)(+dB)				(1m*)(+dB)		(0.5m*)(+dB)
	9kHz -30MHz	30MHz -300MHz	300MHz -1GHz	1GHz -10GHz	10GHz -18GHz	18GHz -26.5GHz	26.5GHz -40GHz
No.1	4.0dB	5.1dB	5.0dB	5.1dB	6.0dB	4.9dB	4.3dB
No.2	3.9dB	5.2dB	5.0dB	4.9dB	5.9dB	4.7dB	4.2dB
No.3	4.3dB	5.1dB	5.2dB	5.2dB	6.0dB	4.8dB	4.2dB
No.4	4.6dB	5.2dB	5.0dB	5.2dB	6.0dB	5.7dB	4.2dB

*3m/1m/0.5m = Measurement distance

Radiated emission test (3m)

[Electric Field Strength of Fundamental Emission]

The data listed in this test report has enough margin, more than the site margin.

[Electric Field Strength of Spurious Emission]

The data listed in this report meets the limits unless the uncertainty is taken into consideration.

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3.5 Test Location

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	FCC Registration Number	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms
No.1 semi-anechoic chamber	313583	2973C-1	19.2 x 11.2 x 7.7m	7.0 x 6.0m	No.1 Power source room
No.2 semi-anechoic chamber	655103	2973C-2	7.5 x 5.8 x 5.2m	4.0 x 4.0m	-
No.3 semi-anechoic chamber	148738	2973C-3	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.3 Preparation room
No.3 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.4 semi-anechoic chamber	134570	2973C-4	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.4 Preparation room
No.4 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.5 semi-anechoic chamber	-	-	6.0 x 6.0 x 3.9m	6.0 x 6.0m	-
No.6 shielded room	-	-	4.0 x 4.5 x 2.7m	4.75 x 5.4 m	-
No.6 measurement room	-	-	4.75 x 5.4 x 3.0m	4.75 x 4.15 m	-
No.7 shielded room	-	-	4.7 x 7.5 x 2.7m	4.7 x 7.5m	-
No.8 measurement room	-	-	3.1 x 5.0 x 2.7m	N/A	-
No.9 measurement room	-	-	8.8 x 4.6 x 2.8m	2.4 x 2.4m	-
No.11 measurement room	-	-	3.1 x 3.4 x 3.0m	2.4 x 3.4m	-

* Size of vertical conducting plane (for Conducted Emission test) : 2.0 x 2.0m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Data of EMI, Test instruments, and Test set up.

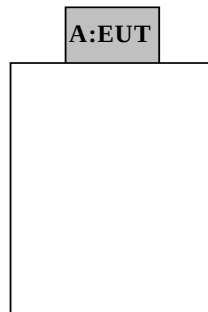
Refer to APPENDIX.

SECTION 4: Operation of E.U.T. during testing

4.1 Operating Modes

Test Item*	Mode
Automatically Deactivate	Normal use mode, ASK/FSK, 314.9MHz
Electric Field Strength of Fundamental Emission Electric Field Strength of Spurious Emission -20dB & 99% Occupied Bandwidth Duty Cycle	Transmitting mode, ASK/FSK, 314.9MHz *1)
* The system was configured in typical fashion (as a customer would normally use it) for testing. *1) The software of this mode is the same as one of normal product, except that EUT continues to transmit when transceiver button is being pressed (For Normal use mode, EUT stops when transceiver button is disengaged.) End users cannot change the settings of the output power of the product.	

4.2 Configuration and peripherals



* Test data was taken under worse case conditions.

Description of EUT

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	Electronic Key	4AA	001	DENSO CORPORATION	EUT

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SECTION 5: Radiated emission (Electric Field Strength of Fundamental and Spurious Emission)

Test Procedure and conditions

EUT was placed on a urethane platform of nominal size, 0.5m by 1.0m, raised 0.8m above the conducting ground plane. The EUT was set on the center of the tabletop.
Test was made with the antenna positioned in both the horizontal and vertical planes of polarization. The measurement antenna was varied in height above the conducting ground plane to obtain the maximum signal strength.
Photographs of the set up are shown in Appendix 1.

[Transmitting mode]

(Below 30MHz)

The noise level was checked by moving a search-coil (Loop Antenna) close to the EUT.

(Above 30MHz)

The Radiated Electric Field Strength has been measured on Semi anechoic chamber with a ground plane and at a distance of 3m.

The measuring antenna height was varied between 1 and 4m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.

The measurements were performed for both vertical and horizontal antenna polarization.

The radiated emission measurements were made with the following detector function of the test receiver/spectrum analyzer.

Test Antennas are used as below;

Frequency	Below 30MHz	30MHz to 300MHz	300MHz to 1GHz	Above 1GHz
Antenna Type	Loop	Biconical	Logperiodic	Horn

	From 9kHz to 90kHz and From 110kHz to 150kHz	From 90kHz to 110kHz	From 150kHz to 490kHz	From 490kHz to 30MHz	From 30MHz to 1GHz	Above 1GHz
Detector Type	Peak	Peak	Peak	Peak	Peak and Peak with Duty factor	Peak and Peak with Duty factor
IF Bandwidth	200Hz	200Hz	9.1kHz	9.1kHz	120kHz	PK: S/A:RBW 1MHz, VBW 3MHz

- The carrier level was measured at each position of all three axes X, Y and Z, and the position that has the maximum noise was determined.

Noise levels of all the frequencies were measured at the position.

This EUT has two modes which mechanical key is inserted or not. The worst case was confirmed with and without mechanical key, as a result, the test with mechanical key was the worst case. Therefore the test with mechanical key was performed only.

*The result is rounded off to the second decimal place, so some differences might be observed.

Measurement range : 9kHz-3.2GHz
Test data : APPENDIX
Test result : Pass

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SECTION 6: Automatically deactivate

Test Procedure

The measurement was performed with Electric field strength using a spectrum analyzer.

Test data : APPENDIX
Test result : Pass

SECTION 7: -20dB and 99% Occupied Bandwidth

Test Procedure

The measurement was performed in the antenna height to gain the maximum of Electric field strength.

Test	Span	RBW	VBW	Sweep	Detector	Trace	Instrument used
20dB Bandwidth	300kHz	3kHz	9.1kHz	Auto	Peak	Max Hold	Spectrum Analyzer
99% Occupied Bandwidth	Enough width to display 20dB Bandwidth	1 % of Span	Three times of RBW	Auto	Peak *1)	Max Hold *1)	Spectrum Analyzer
*1) The measurement was performed with Peak detector, Max Hold since the duty cycle was not 100%.							

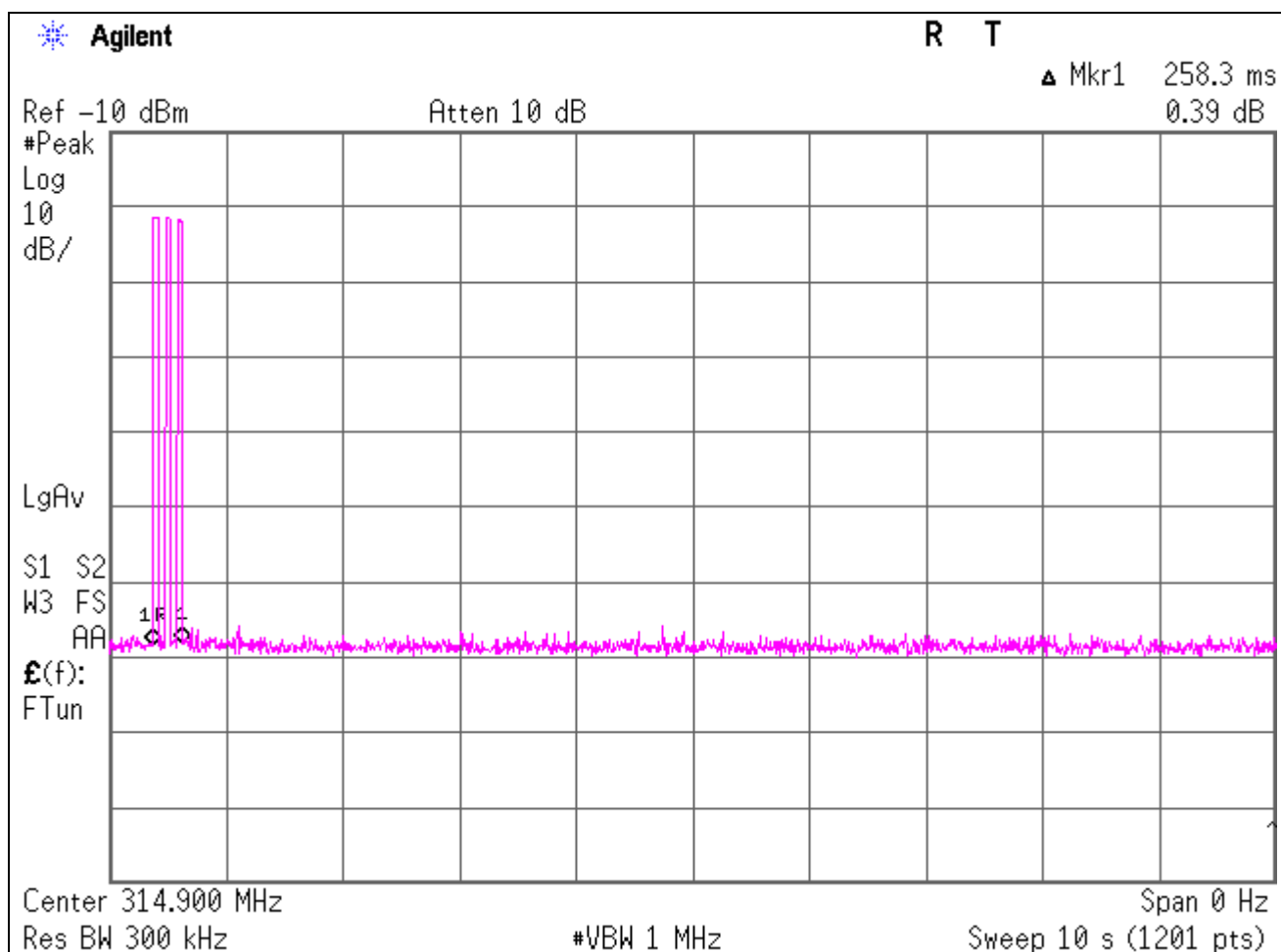
Test data : APPENDIX
Test result : Pass

APPENDIX 1: Data of EMI test

Automatically deactivate

Test place	Head Office EMC Lab. No.4 Semi Anechoic Chamber
Report No.	10082424H
Date	10/20/2013
Temperature/ Humidity	21 deg. C / 68% RH
Engineer	Satofumi Matsuyama
Mode	Normal use mode ASK (314.9MHz)

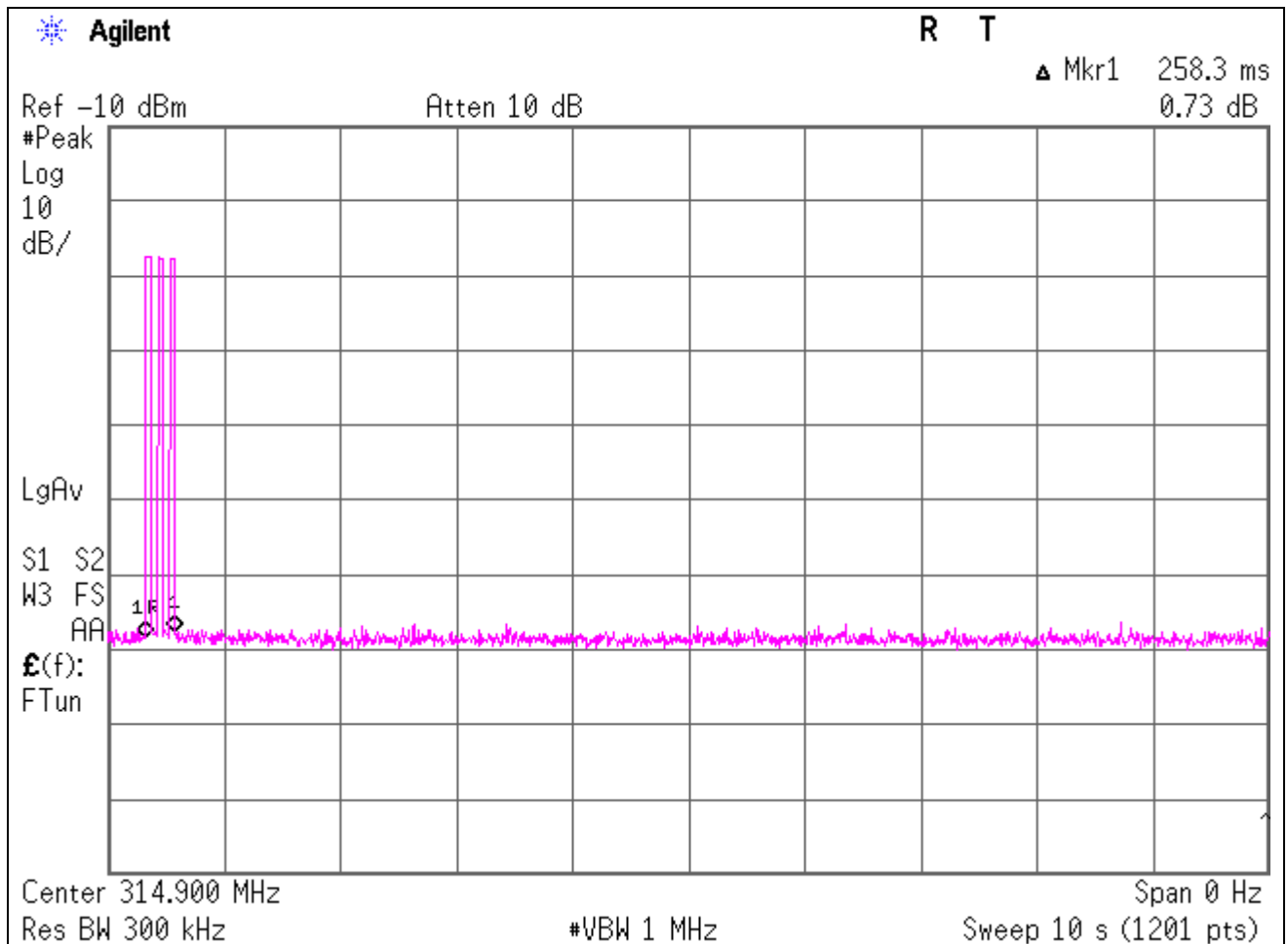
Time of Transmitting [sec]	Limit [sec]	Result
0.258	5.00	Pass



Automatically deactivate

Test place Head Office EMC Lab. No.4 Semi Anechoic Chamber
Report No. 10082424H
Date 10/20/2013
Temperature/ Humidity 21 deg. C / 68% RH
Engineer Satofumi Matsuyama
Mode Normal use mode FSK (314.9MHz)

Time of Transmitting [sec]	Limit [sec]	Result
0.258	5.00	Pass



Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission)

Test place Head Office EMC Lab. No.2 and 4 Shielded room
Report No. 10082424H
Date 10/18/2013 10/20/2013
Temperature/ Humidity 22 deg. C / 41% RH 21 deg. C / 68% RH
Engineer Masatoshi Nishiguchi Satofumi Matsuyama
Mode Transmitting mode ASK (314.9MHz)

PK

Frequency [MHz]	Detector	Reading [dBuV]		Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]		Limit dBuV/m	Margin [dB]		Remark Inside or Outside of Restricted Bands
		Hor	Ver					Hor	Ver		Hor	Ver	
314.900	PK	87.6	84.0	14.6	8.9	27.8	-	83.3	79.7	95.6	12.3	15.9	Carrier
629.800	PK	31.9	30.6	19.5	10.3	28.8	-	32.9	31.6	75.6	42.7	44.0	Outside
944.700	PK	47.1	42.9	22.7	11.5	27.7	-	53.6	49.4	75.6	22.0	26.2	Outside
1259.600	PK	46.7	49.5	25.1	1.9	34.2	-	39.5	42.3	75.6	36.1	33.3	Outside
1574.500	PK	48.0	50.8	25.9	2.1	33.4	-	42.6	45.4	73.9	31.3	28.5	Inside
1889.400	PK	57.1	54.3	26.6	2.3	32.9	-	53.1	50.3	75.6	22.5	25.3	Outside
2204.300	PK	51.5	49.2	27.6	2.5	32.5	-	49.1	46.8	73.9	24.8	27.1	Inside
2519.200	PK	61.5	60.8	28.7	2.7	32.4	-	60.5	59.8	75.6	15.1	15.8	Outside
2834.100	PK	51.5	48.9	29.1	2.9	32.2	-	51.3	48.7	73.9	22.6	25.2	Inside
3149.000	PK	68.4	67.1	29.4	3.0	32.1	-	68.7	67.4	75.6	6.9	8.2	Outside

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter) - Gain(Amplifier)

PK with Duty factor

Frequency [MHz]	Detector	Reading [dBuV]		Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]		Limit dBuV/m	Margin [dB]		Remark
		Hor	Ver					Hor	Ver		Hor	Ver	
314.900	PK	87.6	84.0	14.6	8.9	27.8	-14.2	69.1	65.5	75.6	6.5	10.1	Carrier
629.800	PK	31.9	30.6	19.5	10.3	28.8	-14.2	18.7	17.4	55.6	36.9	38.2	Outside
944.700	PK	47.1	42.9	22.7	11.5	27.7	-14.2	39.4	35.2	55.6	16.2	20.4	Outside
1259.600	PK	46.7	49.5	25.1	1.9	34.2	-14.2	25.3	28.1	55.6	30.3	27.5	Outside
1574.500	PK	48.0	50.8	25.9	2.1	33.4	-14.2	28.4	31.2	53.9	25.5	22.7	Inside
1889.400	PK	57.1	54.3	26.6	2.3	32.9	-14.2	38.9	36.1	55.6	16.7	19.5	Outside
2204.300	PK	51.5	49.2	27.6	2.5	32.5	-14.2	34.9	32.6	53.9	19.0	21.3	Inside
2519.200	PK	61.5	60.8	28.7	2.7	32.4	-14.2	46.3	45.6	55.6	9.3	10.0	Outside
2834.100	PK	51.5	48.9	29.1	2.9	32.2	-14.2	37.1	34.5	53.9	16.8	19.4	Inside
3149.000	PK	68.4	67.1	29.4	3.0	32.1	-14.2	54.5	53.2	55.6	1.1	2.4	Outside

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter) - Gain(Amplifier) + Duty factor (Refer to Duty factor data sheet)

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).

Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission)

Test place Head Office EMC Lab. No.2 and 4 Shielded room
Report No. 10082424H
Date 10/18/2013 10/20/2013
Temperature/ Humidity 22 deg. C / 41% RH 21 deg. C / 68% RH
Engineer Masatoshi Nishiguchi Satofumi Matsuyama
Mode Transmitting mode FSK (314.9MHz)

PK

Frequency [MHz]	Detector	Reading [dBuV]		Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]		Limit [dBuV/m]	Margin [dB]		Remark Inside or Outside of Restricted Bands
		Hor	Ver					Hor	Ver		Hor	Ver	
314.900	PK	81.2	77.7	14.6	8.9	27.8	-	76.9	73.4	95.6	18.7	22.2	Carrier
629.800	PK	28.6	28.3	19.5	10.3	28.8	-	29.6	29.3	75.6	46.0	46.3	Outside
944.700	PK	35.7	34.6	22.7	11.5	27.7	-	42.2	41.1	75.6	33.4	34.5	Outside
1259.600	PK	45.5	48.7	25.1	1.9	34.2	-	38.3	41.5	75.6	37.3	34.1	Outside
1574.500	PK	44.3	45.7	25.9	2.1	33.4	-	38.9	40.3	73.9	35.0	33.6	Inside
1889.400	PK	52.5	53.6	26.6	2.3	32.9	-	48.5	49.6	75.6	27.1	26.0	Outside
2204.300	PK	50.0	48.6	27.6	2.5	32.5	-	47.6	46.2	73.9	26.3	27.7	Inside
2519.200	PK	52.3	52.4	28.7	2.7	32.4	-	51.3	51.4	75.6	24.3	24.2	Outside
2834.100	PK	60.8	57.3	29.1	2.9	32.2	-	60.6	57.1	73.9	13.3	16.8	Inside
3149.000	PK	61.6	60.6	29.4	3.0	32.1	-	61.9	60.9	75.6	13.7	14.7	Outside

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter) - Gain(Amplifier)

PK with Duty factor

Frequency [MHz]	Detector	Reading [dBuV]		Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]		Limit [dBuV/m]	Margin [dB]		Remark
		Hor	Ver					Hor	Ver		Hor	Ver	
314.900	PK	81.2	77.7	14.6	8.9	27.8	-9.2	67.7	64.2	75.6	7.9	11.4	Carrier
629.800	PK	28.6	28.3	19.5	10.3	28.8	-9.2	20.4	20.1	55.6	35.2	35.5	Outside
944.700	PK	35.7	34.6	22.7	11.5	27.7	-9.2	33.0	31.9	55.6	22.6	23.7	Outside
1259.600	PK	45.5	48.7	25.1	1.9	34.2	-9.2	29.1	32.3	55.6	26.5	23.3	Outside
1574.500	PK	44.3	45.7	25.9	2.1	33.4	-9.2	29.7	31.1	53.9	24.2	22.8	Inside
1889.400	PK	52.5	53.6	26.6	2.3	32.9	-9.2	39.3	40.4	55.6	16.3	15.2	Outside
2204.300	PK	50.0	48.6	27.6	2.5	32.5	-9.2	38.4	37.0	53.9	15.5	16.9	Inside
2519.200	PK	52.3	52.4	28.7	2.7	32.4	-9.2	42.1	42.2	55.6	13.5	13.4	Outside
2834.100	PK	60.8	57.3	29.1	2.9	32.2	-9.2	51.4	47.9	53.9	2.5	6.0	Inside
3149.000	PK	61.6	60.6	29.4	3.0	32.1	-9.2	52.7	51.7	55.6	2.9	3.9	Outside

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter) - Gain(Amplifier) + Duty factor (Refer to Duty factor data sheet)

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).

-20dB and 99% Occupied Bandwidth

Test place Head Office EMC Lab. No.2 Shielded room
Report No. 10082424H
Date 10/18/2013
Temperature/ Humidity 22 deg. C / 41% RH
Engineer Masatoshi Nishiguchi
Mode Transmitting mode ASK/FSK (314.9MHz)

ASK

Bandwidth Limit : Fundamental Frequency $314.9 \text{ MHz} \times 0.25\% = 787.25 \text{ kHz}$

-20dB Bandwidth [kHz]	Bandwidth Limit [kHz]	Result
28.39	787.25	Pass

99% Occupied Bandwidth [kHz]	Bandwidth Limit [kHz]	Result
95.11	787.25	Pass

FSK

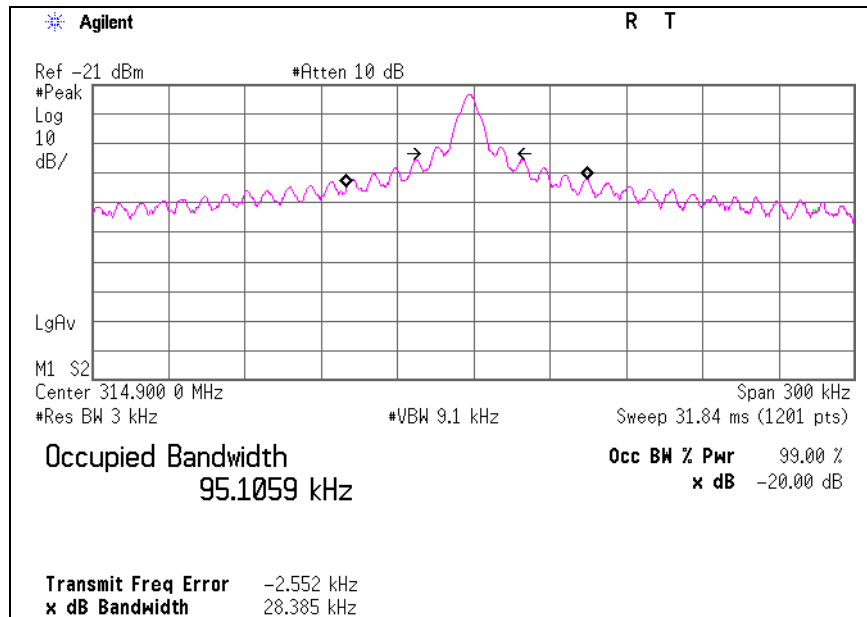
Bandwidth Limit : Fundamental Frequency $314.9 \text{ MHz} \times 0.25\% = 787.25 \text{ kHz}$

-20dB Bandwidth [kHz]	Bandwidth Limit [kHz]	Result
80.89	787.25	Pass

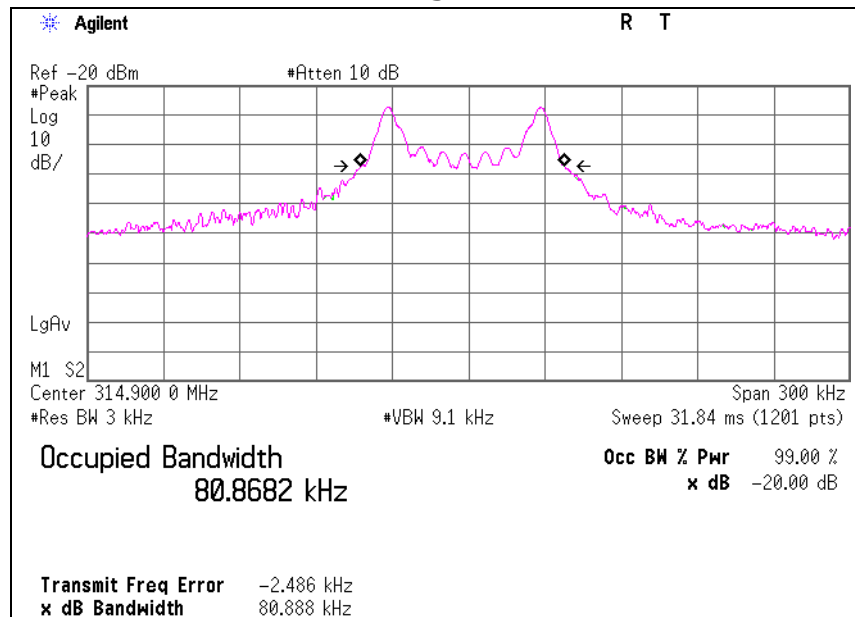
99% Occupied Bandwidth [kHz]	Bandwidth Limit [kHz]	Result
80.87	787.25	Pass

-20dB and 99% Occupied Bandwidth

ASK



FSK



Duty Cycle

Test place	Head Office EMC Lab. No.2 Shielded room
Report No.	10082424H
Date	10/18/2013
Temperature/ Humidity	22 deg. C / 41% RH
Engineer	Masatoshi Nishiguchi
Mode	Transmitting mode ASK (314.9MHz)

Type	Times	ON time(One pulse) [ms]	ON time(in 100ms) [ms]
A	46	0.260	11.9784
B	52	0.143	7.4256

*1)ON time(in 100ms) = Times * ON time(One pulse)

*2)The train of pulses was exceeding 100msec, and that sampled 100msec was the worst case against the pulse train.

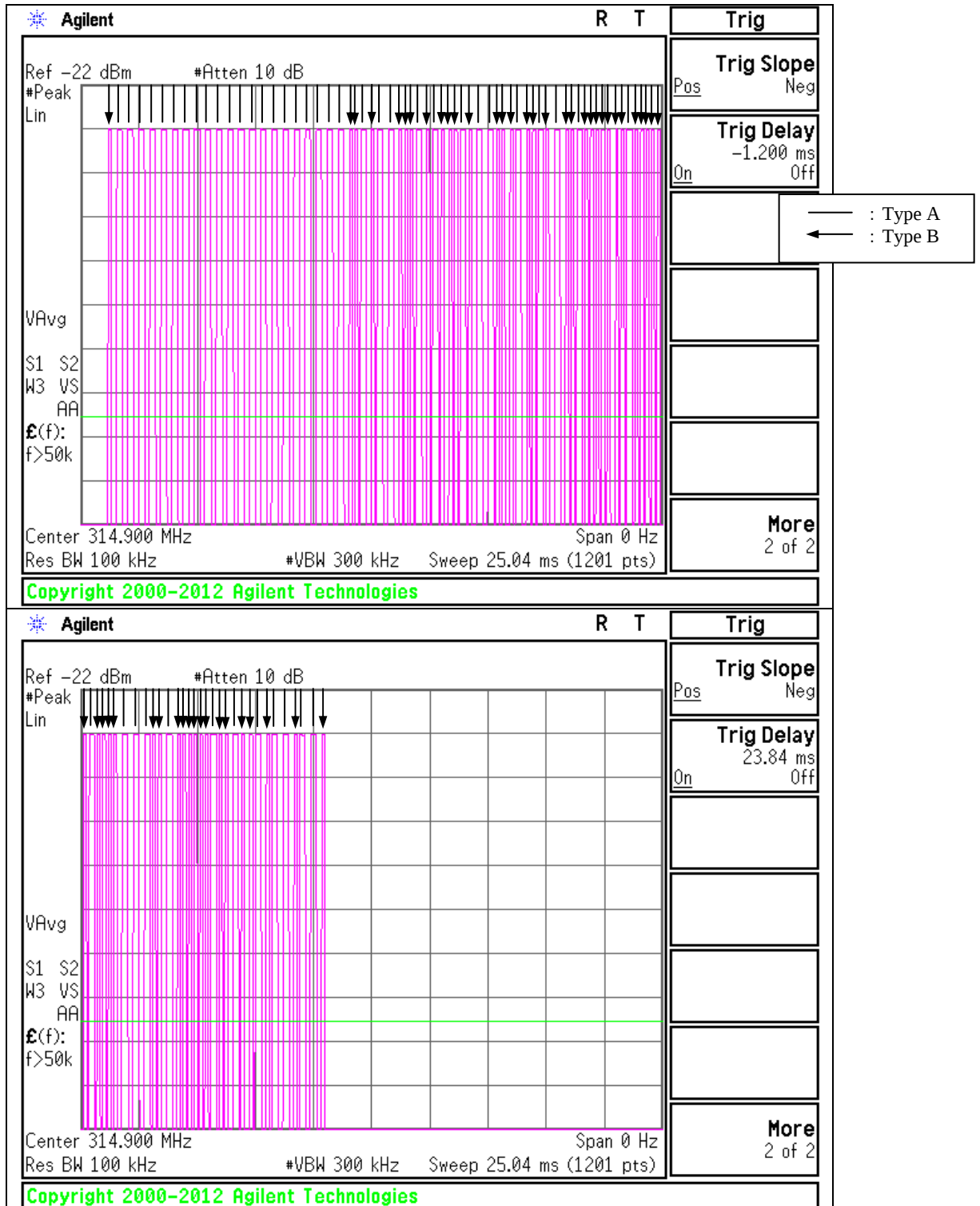
(Total)

ON time [ms]	Cycle [ms]	Duty (On time/Cycle)	Duty [dB]
19.40	100.00	0.19	-14.2

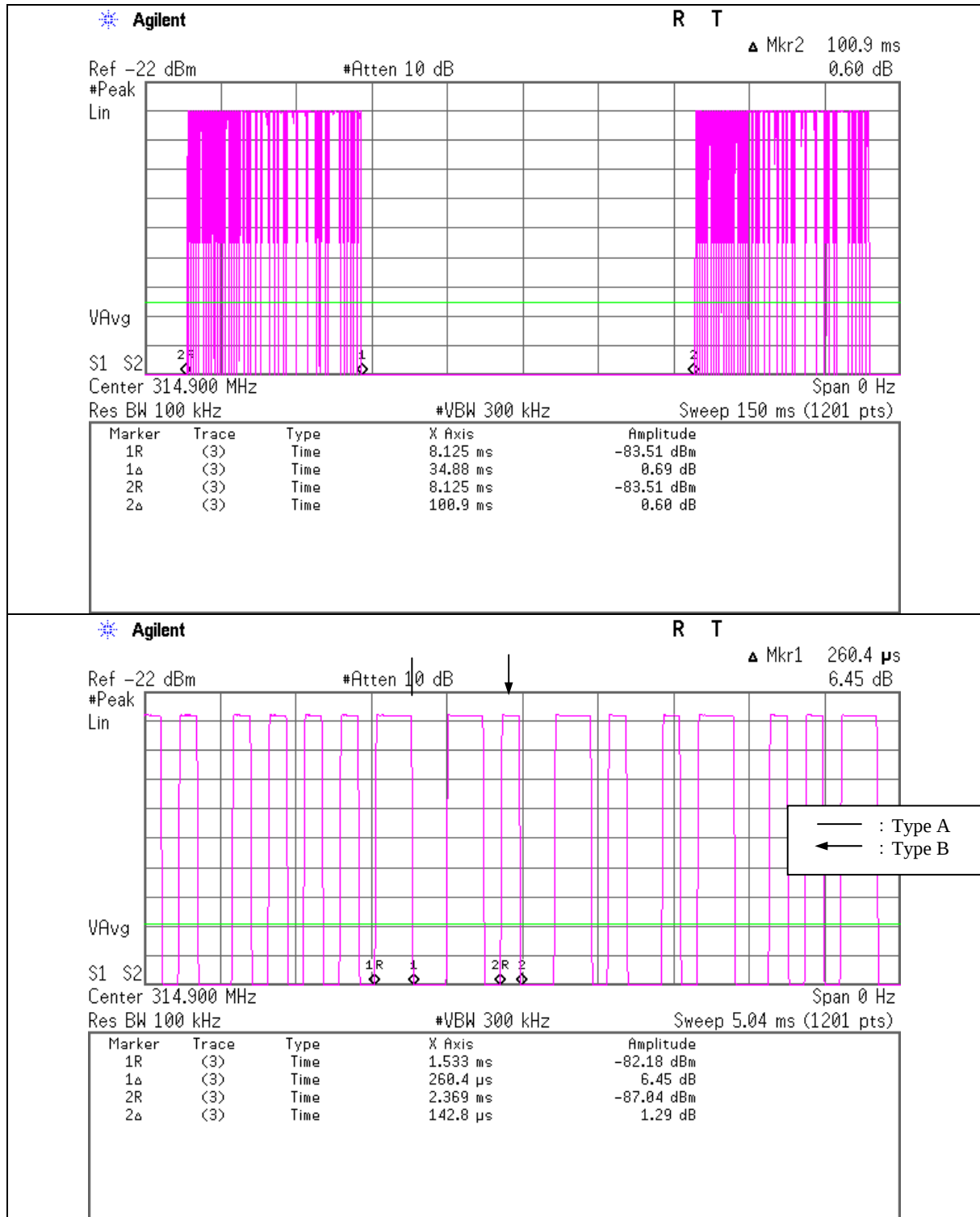
*3)ON time = Type A's ON time (in 100ms) + Type B's ON time (in 100ms)

*4)Duty = $20\log_{10}(\text{ON time/Cycle})$

Duty Cycle



Duty Cycle



Duty Cycle

Test place Head Office EMC Lab. No.2 Shielded room
Report No. 10082424H
Date 10/18/2013
Temperature/ Humidity 22 deg. C / 41% RH
Engineer Masatoshi Nishiguchi
Mode Transmitting mode FSK (314.9MHz)

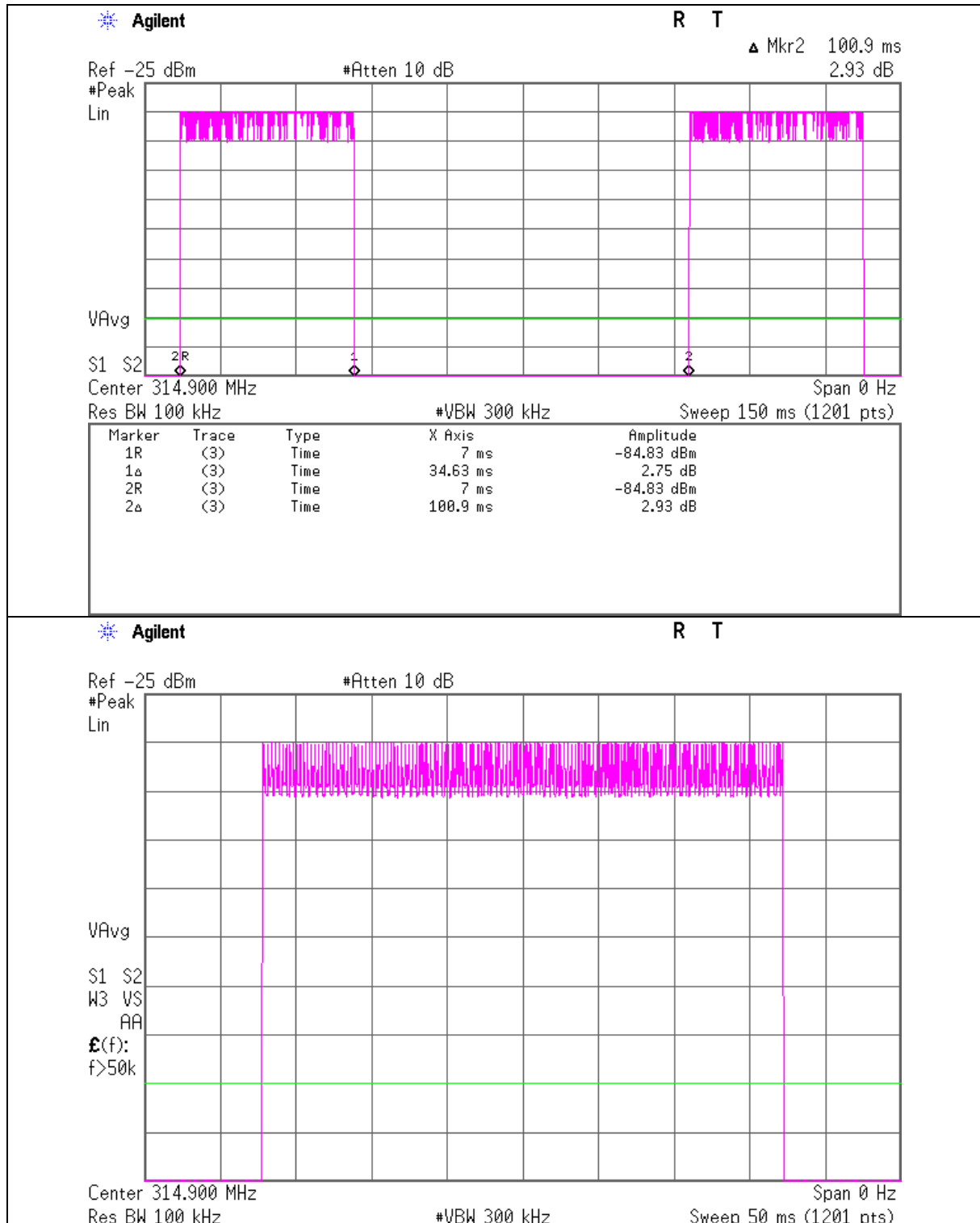
(Total)

ON time [ms]	Cycle [ms]	Duty (On time/Cycle)	Duty [dB]
34.63	100.00	0.35	-9.2

*1)ON time = Type A's ON time (in 100ms) + Type B's ON time (in 100ms)

*2)Duty = $20\log_{10}(\text{ON time/Cycle})$

Duty Cycle



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APPENDIX 2: Test Instruments

EMI test equipment

Control No.	Instrument	Manufacturer	Model No	Serial No	Test Item	Calibration Date * Interval(month)
MAEC-02	Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-06902	RE	2013/06/30 * 12
MOS-22	Thermo-Hygrometer	Custom	CTH-201	0003	RE	2013/02/26 * 12
MJM-14	Measure	KOMELON	KMC-36	-	RE	-
COTS-MEMI	EMI measurement program	TSJ	TEPTO-DV	-	RE	-
MRENT-112	Spectrum Analyzer	Agilent	E4440A	MY48250080	RE	2013/10/04 * 12
MTR-03	Test Receiver	Rohde & Schwarz	ESCI	100300	RE	2013/06/11 * 12
MBA-02	Biconical Antenna	Schwarzbeck	BBA9106	VHA91032008	RE	2012/10/08 * 12
MLA-02	Logperiodic Antenna	Schwarzbeck	USLP9143	201	RE	2012/10/08 * 12
MCC-12	Coaxial Cable	Fujikura/Agilent	-	-	RE	2013/02/06 * 12
MAT-07	Attenuator(6dB)	Weinschel Corp	2	BK7970	RE	2012/11/06 * 12
MPA-09	Pre Amplifier	Agilent	8447D	2944A10845	RE	2013/09/12 * 12
MAEC-04	Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-10005	RE	2013/02/28 * 12
MOS-15	Thermo-Hygrometer	Custom	CTH-180	-	RE	2013/02/26 * 12
MJM-09	Measure	KDS	E19-55	-	RE	-
MSA-04	Spectrum Analyzer	Agilent	E4448A	US44300523	RE	2013/04/03 * 12
MHA-21	Horn Antenna 1-18GHz	Schwarzbeck	BBHA9120D	9120D-557	RE	2013/08/12 * 12
MCC-141	Microwave Cable	Junkosha	MWX221	1305S002R(1m) / 1204S062(5m)	RE	2013/05/28 * 12
MPA-12	MicroWave System Amplifier	Agilent	83017A	MY39500780	RE	2013/03/19 * 12

The expiration date of the calibration is the end of the expired month.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

Test Item:

RE: Radiated emission, 99% Occupied Bandwidth, -20dB bandwidth , Automatically deactivate and Duty cycle tests

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